

## Dual N-Channel Enhancement Mode MOSFET

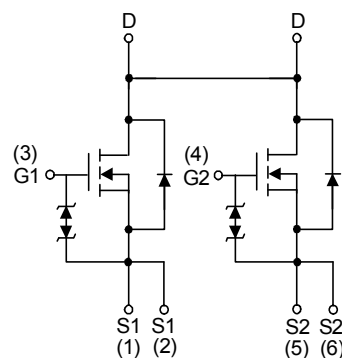
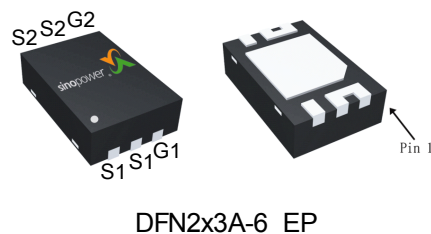
### Features

- 20V/9.7A,  
 $R_{DS(ON)} = 7.5m\Omega$  (Max.) @  $V_{GS}=4.5V$   
 $R_{DS(ON)} = 7.9m\Omega$  (Max.) @  $V_{GS}=4V$   
 $R_{DS(ON)} = 8.2m\Omega$  (Max.) @  $V_{GS}=3.7V$   
 $R_{DS(ON)} = 8.7m\Omega$  (Max.) @  $V_{GS}=3.1V$   
 $R_{DS(ON)} = 9.9m\Omega$  (Max.) @  $V_{GS}=2.5V$
- ESD protection
- 100% UIS Tested
- Reliable and Rugged
- Lead Free and Green Devices Available  
(RoHS Compliant)

### Applications

- Power Management in Notebook Computer, Portable Equipment and Battery Powered Systems.
- One Cell Li-ion Battery Pack.

### Pin Description



N-Channel MOSFET

### Ordering and Marking Information

<p>SM9998DS □□□-□□□</p> <p>Assembly Material</p> <p>Handling Code</p> <p>Temperature Range</p> <p>Package Code</p>	<p>Package Code QG : DFN2x3A-6_EP</p> <p>Operating Junction Temperature Range C : -55 to 150 °C</p> <p>Handling Code TR : Tape &amp; Reel</p> <p>Assembly Material G : Halogen and Lead Free Device</p>
<p>SM9998DS QG : <span style="border: 1px solid black; padding: 2px;">99981 XXXXXX</span></p>	<p><span style="border: 1px solid black; padding: 2px;">X XXXXX</span> - Internal Code  <span style="border: 1px solid black; padding: 2px;">XXXXX</span> - Lot Code</p>

Note: SINOPOWER lead-free products contain molding compounds/die attach materials and 100% matte tin plate termination finish; which are fully compliant with RoHS. SINOPOWER lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020D for MSL classification at lead-free peak reflow temperature. SINOPOWER defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

SINOPOWER reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.

**Absolute Maximum Ratings** ( $T_A = 25^\circ\text{C}$  Unless Otherwise Noted)

Symbol	Parameter		Rating	Unit
Common Ratings				
V <sub>DSS</sub>	Drain-Source Voltage		20	V
V <sub>GSS</sub>	Gate-Source Voltage		±12	
T <sub>J</sub>	Maximum Junction Temperature		150	°C
T <sub>STG</sub>	Storage Temperature Range		-55 to 150	
I <sub>S</sub>	Diode Continuous Forward Current	T <sub>A</sub> =25°C	2	A
I <sub>DM</sub> <sup>a</sup>	Pulsed Drain Current	T <sub>A</sub> =25°C	38	A
I <sub>D</sub> <sup>b</sup>	Continuous Drain Current	T <sub>A</sub> =25°C	9.7	A
		T <sub>A</sub> =70°C	7.5	
P <sub>D</sub> <sup>b</sup>	Maximum Power Dissipation	T <sub>A</sub> =25°C	1.0	W
		T <sub>A</sub> =70°C	0.6	
R <sub>θJA</sub> <sup>c</sup>	Thermal Resistance-Junction to Ambient	t ≤ 10s	80	°C/W
		Steady State	127	°C/W
I <sub>AS</sub> <sup>d</sup>	Avalanche Current, Single pulse	L=0.1mH	22	A
E <sub>AS</sub> <sup>d</sup>	Avalanche Energy, Single pulse	L=0.1mH	24.2	mJ

Note a : Pulse width is limited by max. junction temperature.

Note b :  $t = 999\text{sec}$ .

Note c :  $R_{\theta JA}$  steady state  $t = 999\text{s}$ .  $R_{\theta JA}$  is measured with the device mounted on  $1\text{in}^2$ , FR-4 board with 2oz. Copper.

Note d : UIS tested and pulse width limited by maximum junction temperature  $150^\circ\text{C}$  (initial temperature  $T_J = 25^\circ\text{C}$ ).

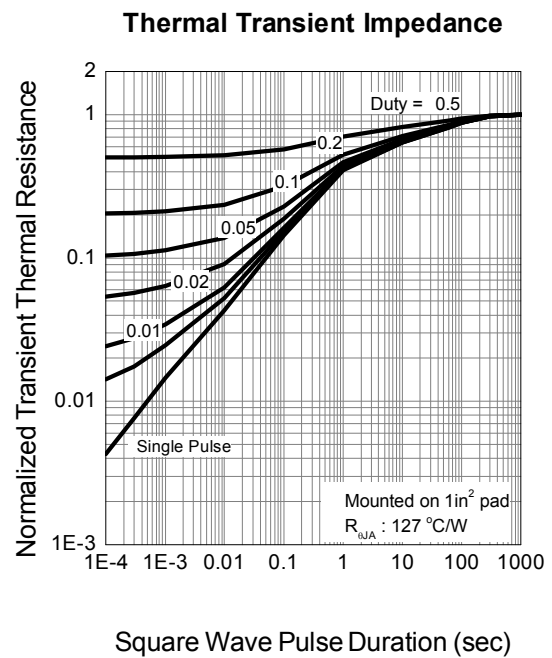
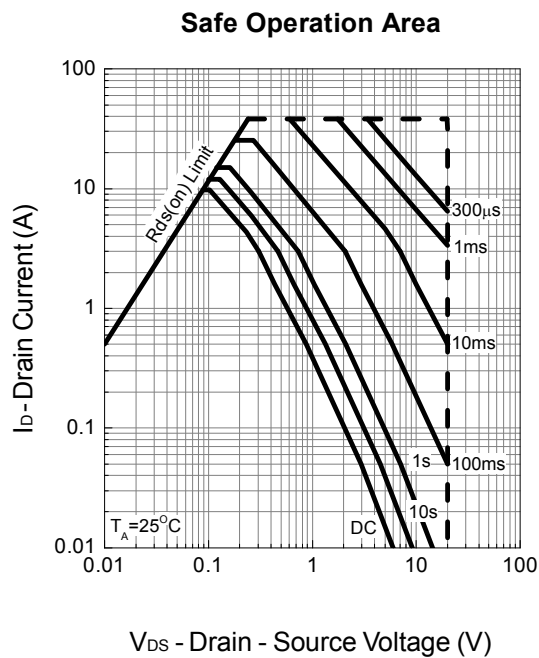
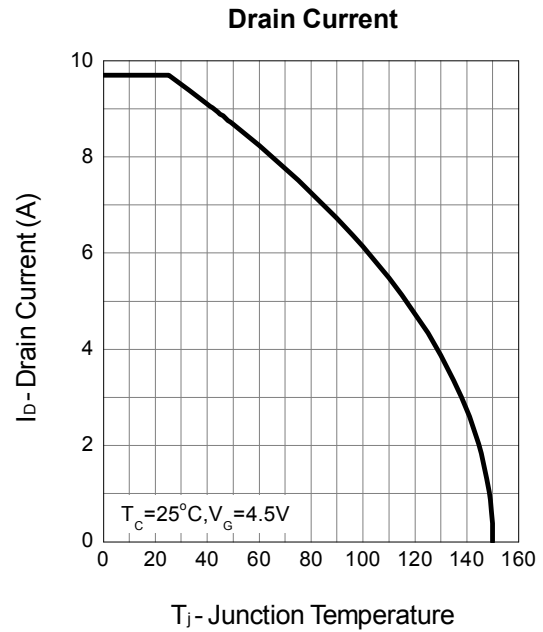
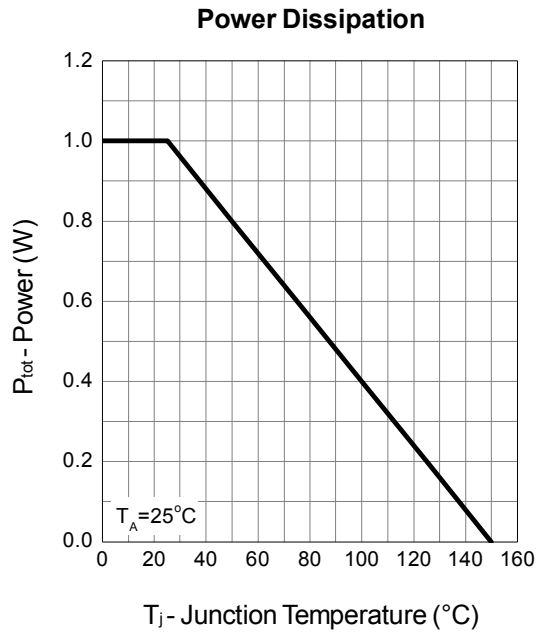
## Electrical Characteristics ( $T_A = 25^\circ\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Characteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>DS</sub> =250μA	20	-	-	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =16V, V <sub>GS</sub> =0V T <sub>J</sub> =85°C	-	-	1 30	μA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250μA	0.5	0.7	1	V
I <sub>GSS</sub>	Gate Leakage Current	V <sub>GS</sub> =±12V, V <sub>DS</sub> =0V	-	-	±10	μA
R <sub>DS(ON)</sub> <sup>e</sup>	Drain-Source On-state Resistance	V <sub>GS</sub> =4.5V, I <sub>DS</sub> =5.5A	4.2	6	7.5	mΩ
		V <sub>GS</sub> =4.0V, I <sub>DS</sub> =5.5A	4.3	6.2	7.9	
		V <sub>GS</sub> =3.7V, I <sub>DS</sub> =5.5A	4.4	6.3	8.2	
		V <sub>GS</sub> =3.1V, I <sub>DS</sub> =5.5A	4.5	6.6	8.7	
		V <sub>GS</sub> =2.5V, I <sub>DS</sub> =5.5A	4.7	7.3	9.9	
Diode Characteristics						
V <sub>SD</sub> <sup>e</sup>	Diode Forward Voltage	I <sub>SD</sub> =1A, V <sub>GS</sub> =0V	-	0.7	1.3	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>SD</sub> =5.5A, dI <sub>SD</sub> /dt=100A/μs	-	445	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge		-	2175	-	nC
Dynamic Characteristics <sup>f</sup>						
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz	-	11	-	Ω
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =10V, Frequency=1.0MHz	-	1470	1920	pF
C <sub>oss</sub>	Output Capacitance		-	258	-	
C <sub>rss</sub>	Reverse Transfer Capacitance		-	202	-	
t <sub>d(ON)</sub>	Turn-on Delay Time	V <sub>DD</sub> =10V, R <sub>L</sub> =10Ω, I <sub>DS</sub> =1A, V <sub>GEN</sub> =10V, R <sub>G</sub> =1Ω	-	8	15	ns
t <sub>r</sub>	Turn-on Rise Time		-	20	36	
t <sub>d(OFF)</sub>	Turn-off Delay Time		-	935	1683	
t <sub>f</sub>	Turn-off Fall Time		-	410	738	
Gate Charge Characteristics <sup>f</sup>						
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =10V, V <sub>GS</sub> =4.5V, I <sub>DS</sub> =5.5A	-	23.2	33	nC
Q <sub>gs</sub>	Gate-Source Charge		-	1.9	-	
Q <sub>gd</sub>	Gate-Drain Charge		-	4.8	-	

Note e : Pulse test ; pulse width $\leq 300\mu s$ , duty cycle $\leq 2\%$ .

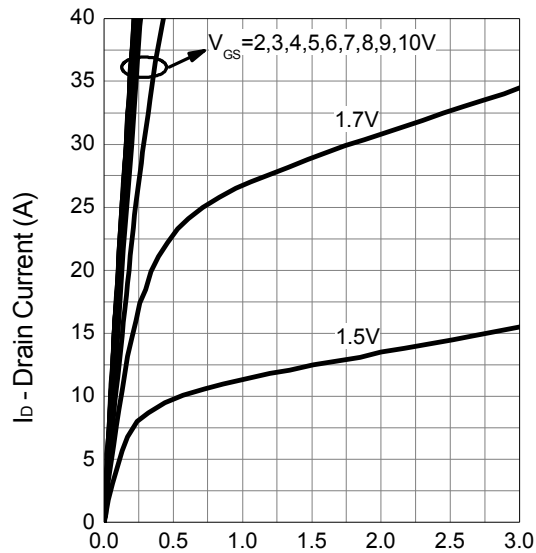
Note f : Guaranteed by design, not subject to production testing.

## Typical Operating Characteristics



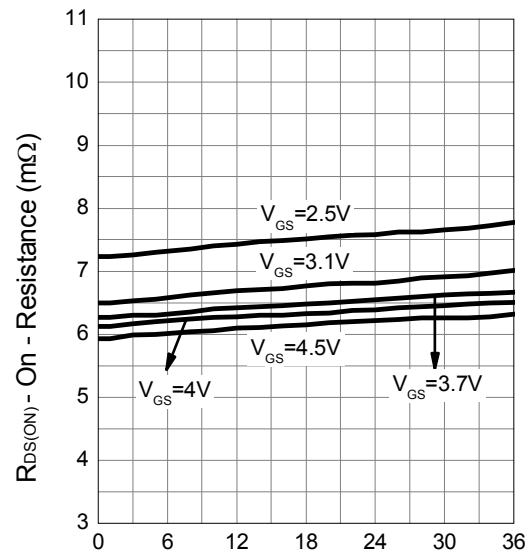
## Typical Operating Characteristics (Cont.)

**Output Characteristics**



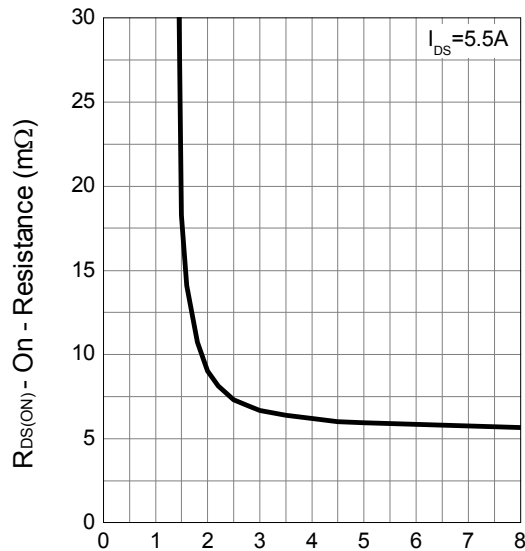
$V_{DS}$  - Drain - Source Voltage (V)

**Drain-Source On Resistance**



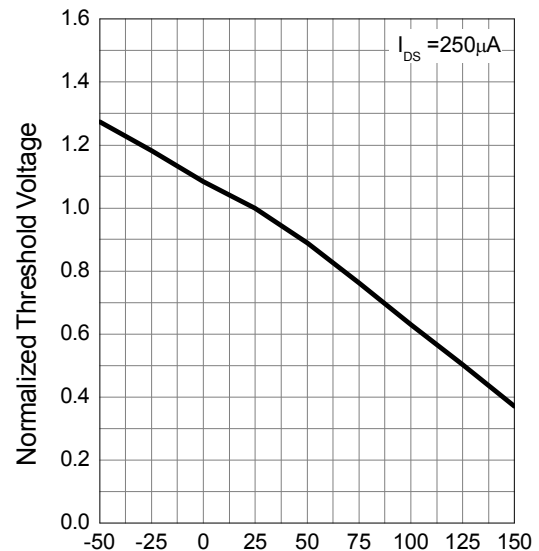
$I_D$  - Drain Current (A)

**Gate-Source On Resistance**



$V_{GS}$  - Gate - Source Voltage (V)

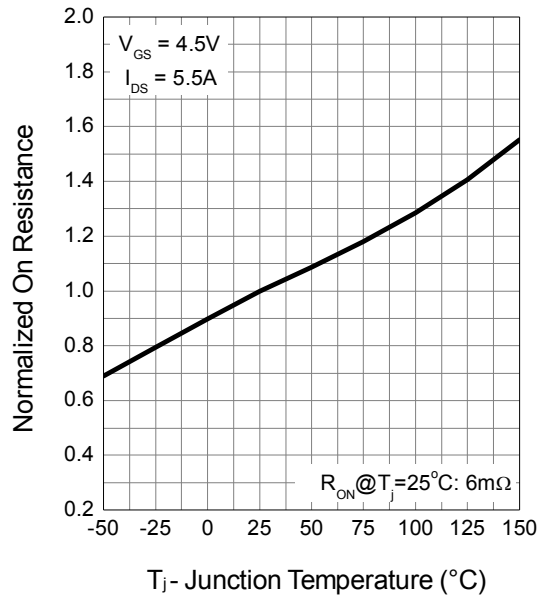
**Gate Threshold Voltage**



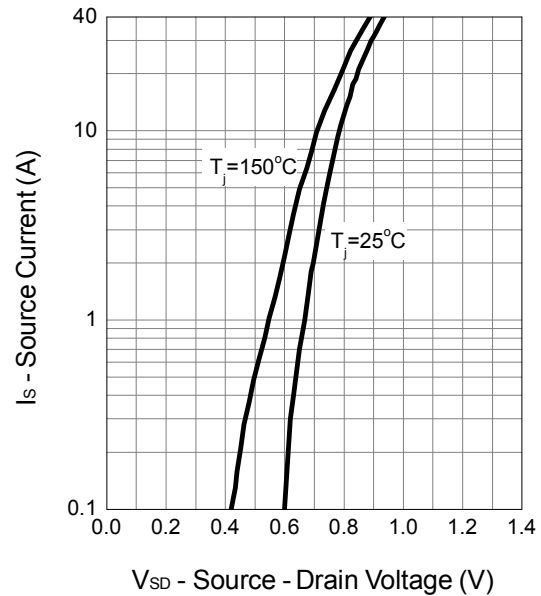
$T_J$  - Junction Temperature ( $^{\circ}C$ )

## Typical Operating Characteristics (Cont.)

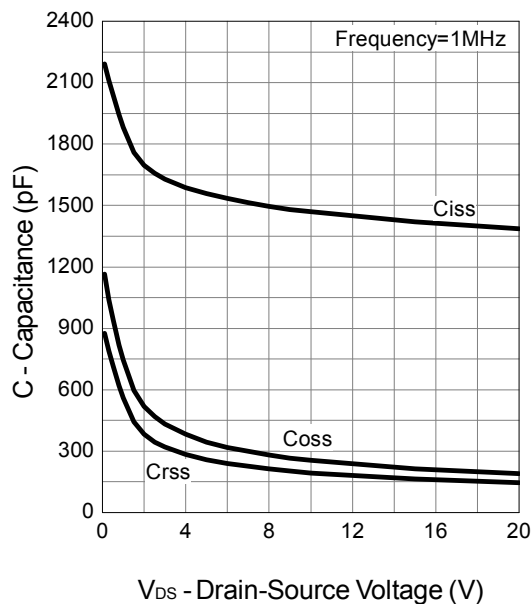
**Drain-Source On Resistance**



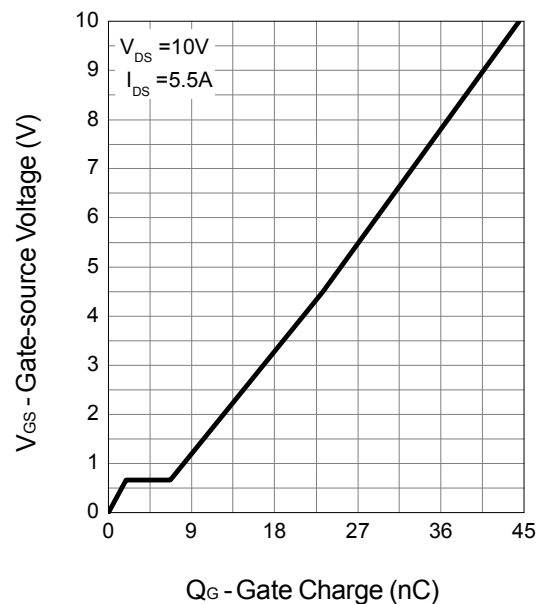
**Source-Drain Diode Forward**



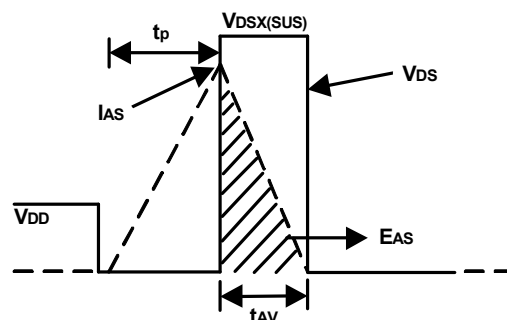
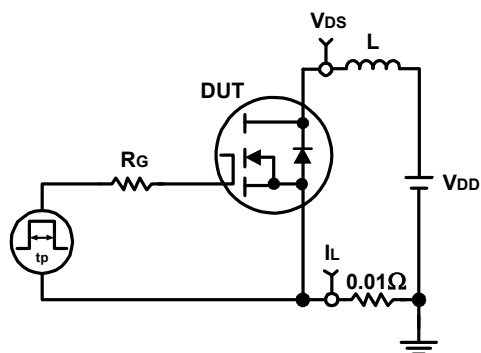
**Capacitance**



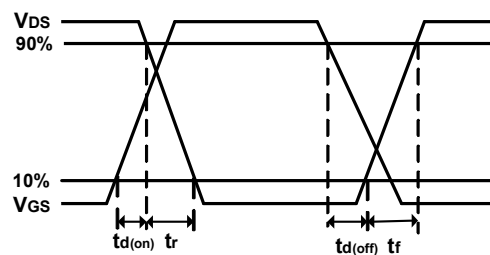
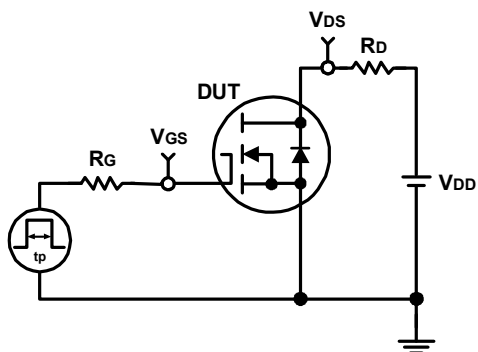
**Gate Charge**



## Avalanche Test Circuit and Waveforms



## Switching Time Test Circuit and Waveforms



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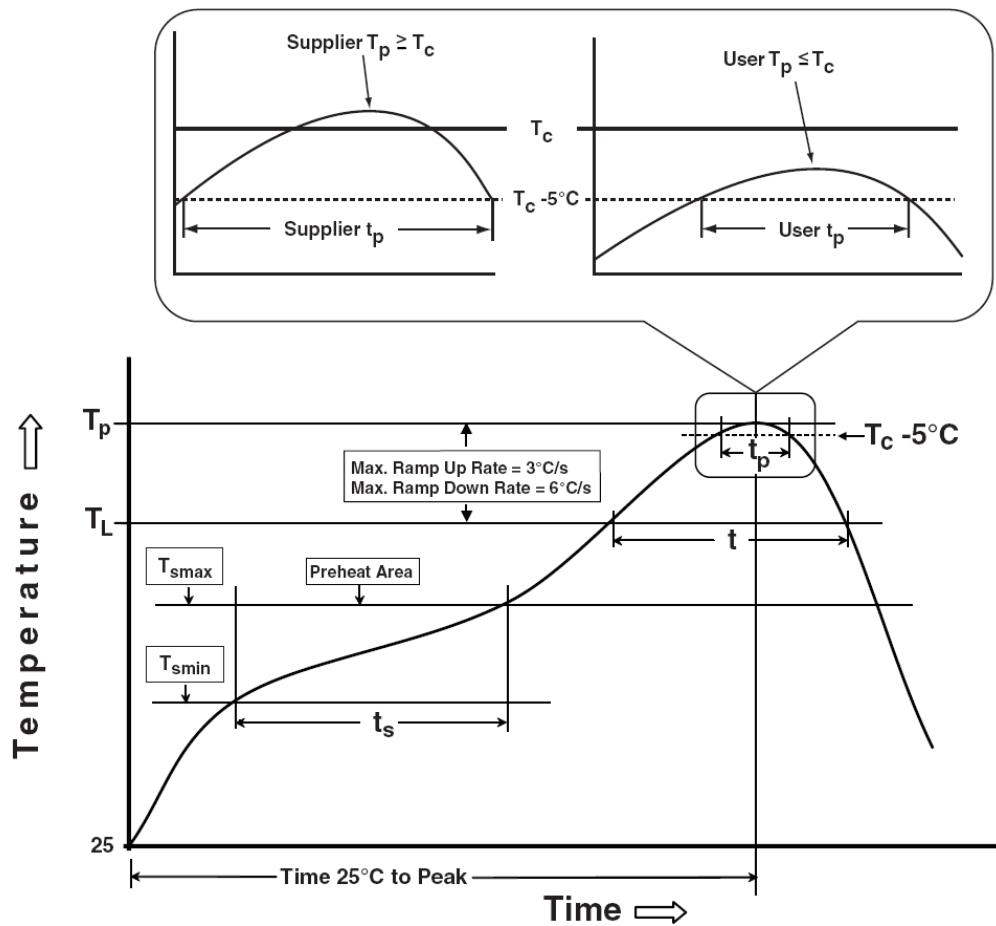
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## Classification Profile



## Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
<b>Preheat &amp; Soak</b>		
Temperature min ( $T_{smin}$ )	100 °C	150 °C
Temperature max ( $T_{smax}$ )	150 °C	200 °C
Time ( $T_{smin}$ to $T_{smax}$ ) ( $t_s$ )	60-120 seconds	60-120 seconds
Average ramp-up rate ( $T_{smax}$ to $T_p$ )	3 °C/second max.	3°C/second max.
Liquidous temperature ( $T_L$ )	183 °C	217 °C
Time at liquidous ( $t_L$ )	60-150 seconds	60-150 seconds
Peak package body Temperature ( $T_p$ )*	See Classification Temp in table 1	See Classification Temp in table 2
Time ( $t_p$ )** within 5°C of the specified classification temperature ( $T_c$ )	20** seconds	30** seconds
Average ramp-down rate ( $T_p$ to $T_{smax}$ )	6 °C/second max.	6 °C/second max.
Time 25°C to peak temperature	6 minutes max.	8 minutes max.
* Tolerance for peak profile Temperature ( $T_p$ ) is defined as a supplier minimum and a user maximum.		
** Tolerance for time at peak profile temperature ( $t_p$ ) is defined as a supplier minimum and a user maximum.		

Table 1. SnPb Eutectic Process – Classification Temperatures ( $T_c$ )

Package Thickness	Volume mm <sup>3</sup> <350	Volume mm <sup>3</sup> ≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2. Pb-free Process – Classification Temperatures ( $T_c$ )

Package Thickness	Volume mm <sup>3</sup> <350	Volume mm <sup>3</sup> 350-2000	Volume mm <sup>3</sup> >2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

## Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	1000 Hrs, 80% of VDS max @ $T_{jmax}$
HTGB	JESD-22, A108	1000 Hrs, 100% of VGS max @ $T_{jmax}$
PCT	JESD-22, A102	168 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -65°C~150°C

## Customer Service

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